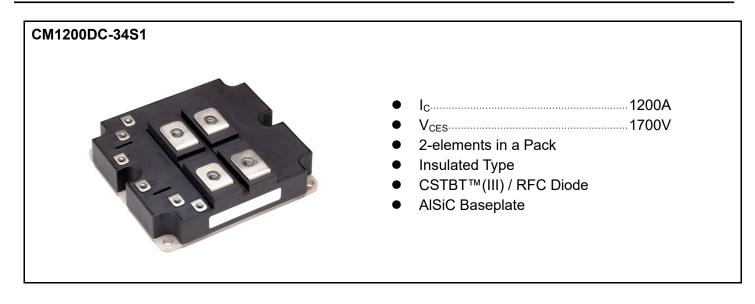


< High Voltage Insulated Gate Bipolar Transistor: HVIGBT >

CM1200DC-34S1

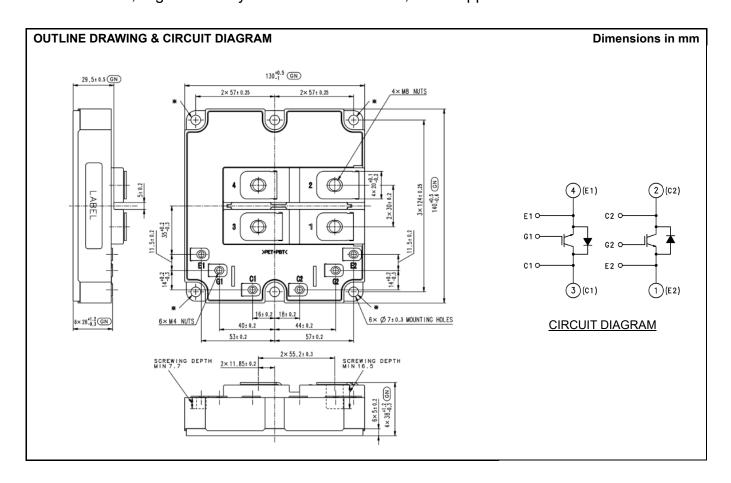
HIGH POWER SWITCHING USE INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules



APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers



< High Voltage Insulated Gate Bipolar Transistor : HVIGBT >

CM1200DC-34S1 HIGH POWER SWITCHING USE INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

MAXIMUM RATINGS

Item	Symbol	Conditions			Unit
Collector-emitter voltage Gate-emitter short-circuited	V _{CES}	$V_{GE} = 0 \text{ V}$ $T_{I} = -40^{\circ} + 150 \text{ °C}$ $T_{I} = -50 \text{ °C}$			V
Gate-emitter voltage Collector-emitter short-circuited	V_{GES}	′ _{CE} = 0 V			V
Collector current	Ic	$T_c = 90 ^{\circ}\text{C}$, DC	= 90 °C , DC		
(Repetitive peak) Collector current	I _{CRM}	Pulse (Note 1)		2400	Α
Emitter current	Ι _Ε	DC (Note 2)		1200	Α
(Repetitive peak) Emitter current	I _{ERM}	ulse (Note 1, 2)			Α
Total power dissipation	P _{tot}	c = 25 °C , IGBT part(Note 3)			W
Isolation voltage	V _{isol}	/sol RMS sinusoidal, 60Hz 1min			V _{rms}
Partial discharge charge	Q_{pd}	Charged part to the baseplate, RMS sinusoidal, 60 Hz $V_1 = 3500 \text{ V}$, $V_2 = 2600 \text{ V}$, (acc. to IEC 61287-1)			рС
Junction temperature	T _i	Maximum temperature range in off-state or on-state(non-switching)			°C
Storage temperature	T _{stq}	Maximum case temperature range in off-state			°C
Operating junction temperature	T _{jop}	Maximum junction temperature range for switching operation			°C
Turn-off cllector current	I _{C(off)}	$V_{GE} = \pm 15 \text{ V}$, $L_s = 70 \text{ nH}$, $R_{G(off)} = 3.3 \Omega$, $V_{CC} \le 1200 \text{ V}$, $V_{CE} \le 1700 \text{ V}$ $T_j = 150 \text{ °C}$		2400	Α
Short-circuit withstand pulse duration	t _{pSC}	$V_{GE} = \pm 15 \text{ V}$, $L_s \le 70 \text{ nH}$, $R_{G(off)} = 3.3 \Omega$, $VCC \le 1200 \text{ V}$, $V_{CE} \le 1700 \text{ V}$	T _i = 150 °C	10	μs
Reverse recovery power dissipation	P _{rr}	$I_E = 2400 \text{ A}$, $L_s = 70 \text{ nH}$, $V_{CC} \le 1200 \text{V}$, $di/dt \le 8000 \text{A/us}$, $V_{CE} \le 1700 \text{V}$ $T_i = 150 \text{ °C}$			MW

ELECTRICAL CHARACTERISTICS

Item	Cumbal	Conditions		Limits			Unit
nem	Symbol	Conditions		Min.		Max.	Unit
Collector-emitter cut-off current	1	V _{CF} = 1700 V , V _{CF} = 0 V	T _j = 25 °C T _i = 125 °C	-	- 1.8	4.0	mA mA
Gate-emitter short-circuited	I _{CES}	VCE - 1700 V , VGE - 0 V	$T_i = 125 \text{ °C}$	-	-	40.0	mA
Gate-emitter threshold voltage	$V_{GE(th)}$	V _{CE} = 10 V , I _C = 120mA	T _i = 25 °C	5.40	6.00	6.60	V
Gate leakage current Collector-emitter short-circuited		V _{CE} = 0 V , V _{GE} = ±20 V	T _j = 25 °C	-0.5	-	0.5	μA
Gate charge	Q_G	$V_{CC} = 850 \text{ V}$, $I_{C} = 1200 \text{ A}$, $V_{GE} = \pm 15 \text{ V}$	T _i = 25 °C	-	12.0	-	μC
Input capacitance	C _{ies}	$V_{CE} = 10 \text{ V}$, $V_{GE} = 0 \text{ V}$, $f = 100 \text{kHz}$	T _i = 25 °C	-	216	-	nF
Output capacitance	C _{oes}	$V_{CE} = 10 \text{ V}$, $V_{GE} = 0 \text{ V}$, $f = 100 \text{kHz}$	T _j = 25 °C	-	8.0	-	nF
Reverse transfer capacitance	C _{res}	$V_{CE} = 10 \text{ V}$, $V_{GE} = 0 \text{ V}$, $f = 100 \text{kHz}$	T _j = 25 °C	-	1.6	-	nF
Collector-emitter saturation voltage		I _C = 1200 A , V _{GE} = +15 V(Note 4)	T _j = 25 °C	-	1.95	-	V
	V _{CEsat}		T _i = 125 °C	-	2.25	-	V
			T _j = 150 °C	-	2.30	2.80	V
		I _E = 1200 A , V _{GE} = 0 V(Note 2, 4)	T _j = 25 °C	-	2.20	-	V
Emitter-collector voltage	V _{EC}		T _j = 125 °C	-	2.35	-	V
			T _i = 150 °C	-	2.35	2.85	V
Turn-on delay time	$t_{d(on)}$		T _i = 150 °C	-	-	1.10	μs
Rise time	t _r		T _j = 150 °C	-	-	0.41	μs
Turns on (auditable a) are successive		V - 950 V I - 1200 A V - ±15 V I - 70 pH	T _j = 25 °C	-	265	-	mJ
Turn-on (switching) energy per pulse 10% integral	E _{on(10%)}	$V_{\rm CC} = 850 \text{ V}$, $I_{\rm C} = 1200 \text{ A}$, $V_{\rm GE} = \pm 15 \text{ V}$, $L_{\rm s} = 70 \text{ nH}$ $R_{\rm G(on)} = 1.3 \ \Omega$, $R_{\rm G(off)} = 3.3 \ \Omega$	T _j = 125 °C	-	350	-	mJ
			T _i = 150 °C	-	355	-	mJ
	E _{on}	Inductive load(Note 5)	T _i = 25 °C	-	290	-	mJ
Turn-on (switching) energy per pulse			T _i = 125 °C	-	370	-	mJ
			T _i = 150 °C	-	380	-	mJ

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

ELECTRICAL CHARACTERISTICS

Item	Symbol	Conditions			Limits		Unit
1.6111	Cymbol	Containonio	Conditions		Тур.	Max.	Ö
Reverse recovery time			T _j = 25 °C	-	0.30	-	μs
	t _{rr}		T _i = 125 °C	-	0.40	-	μs
			T _i = 150 °C	-	0.45	-	μs
			T _j = 25 °C	-	735	-	Α
Reverse recovery current	I _{rr}		T _j = 125 °C	-	865	-	Α
			T _j = 150 °C	-	875	-	Α
			T _j = 25 °C	-	190	-	μC
Reverse recovery charge 10% integral	$Q_{rr(10\%)}$	V_{CC} = 850 V , I_{E} = 1200 A , V_{GE} = ±15 V , L_{s} = 70 nH	T _j = 125 °C	-	295	-	μC
		$R_{G(on)} = 1.3 \Omega$, $R_{G(off)} = 3.3 \Omega$	T _i = 150 °C	-	365	-	μC
		Inductive load(Note 2, 5, 6)	T _i = 25 °C	-	265	-	μC
Reverse recovered charge	Q_{rr}	inductive load(Note 2, 3, 0)	T _i = 125 °C	-	340	-	μC
			T _j = 150 °C	-	420	-	μC
Reverse recovery energy			T _j = 25 °C	-	90	-	mJ
per pulse 10% integral	E _{rec(10%)}		T _j = 125 °C	-	150	-	mJ
			T _j = 150 °C	-	195	-	mJ
			T _i = 25 °C	-	150	-	mJ
Reverse recovery energy	E_{rec}		T _i = 125 °C	-	190	-	mJ
			T _j = 150 °C	-	240	-	mJ
			T _j = 25 °C	-	1.20	-	μs
Turn-off delay time	$t_{d(off)}$		T _j = 125 °C	-	1.30	-	μs
			T _j = 150 °C	-	1.32	-	μs
			T _i = 25 °C	-	0.12	-	μs
Fall time	t_{f}	$V_{CC} = 850 \text{ V}$, $I_C = 1200 \text{ A}$, $V_{GE} = \pm 15 \text{ V}$, $L_s = 70 \text{ nH}$	T _i = 125 °C	-	0.15	-	μs
			T _i = 150 °C	-	0.17	-	μs
Turn-off (switching) energy per pulse 10% integral		$R_{G(on)} = 1.3 \Omega$, $R_{G(off)} = 3.3 \Omega$ Inductive load(Note 5)	T _j = 25 °C	-	200	-	mJ
	E _{off(10%)}	Inductive load(140te 3)	T _j = 125 °C	-	280	-	mJ
			T _j = 150 °C	-	310	-	mJ
			T _j = 25 °C	-	260	-	mJ
Turn-off (switching) energy per pulse	E_{off}		T _i = 125 °C	-	360	-	mJ
			T _i = 150 °C	_	400	-	mJ

Note1. Pulse width and repetition rate should be such that junction temperature (T_j) does not exceed T_{jopmax} rating.

Note2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWD_i).

Note3. Junction temperature (T_j) should not exceed T_{jmax} rating (150°C).

Note4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

Note5. The integration range of switching energies ($E_{on(10\%)}$, $E_{rec(10\%)}$, $E_{off(10\%)}$) is from $10\%V_{CE}$ to $10\%I_{C}(10\%I_{E})$.

Note6. The integration range of reverse recovery charge($Q_{rr(10\%)}$) is from I_E = 0A to 10% I_E .

< High Voltage Insulated Gate Bipolar Transistor : HVIGBT >

CM1200DC-34S1 HIGH POWER SWITCHING USE INSULATED TYPE

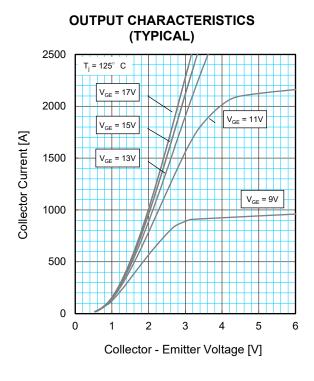
5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

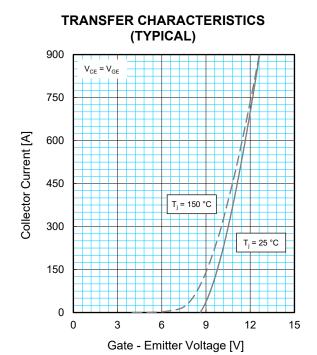
THERMAL CHARACTERISTICS

Item Sy	Symbol	mbol Conditions	Limits			Unit
	Symbol		Min.	Тур.	Max.	Offic
Thermal resistance junction to case, IGBT	$R_{\text{th(j-c)Q}}$	Junction to Case, IGBT part, 1/2 module	-	1	18.5	K/kW
Thermal resistance Junction to case, DIODE	$R_{\text{th(j-c)D}}$	Junction to Case, FWDi part, 1/2 module	-	1	38.0	K/kW
Contact thermal resistance case to heatsink	$R_{\text{th(c-s)}}$	Case to heat sink, 1/2 module λ_{grease} = 1 W/m·k, $D_{(c-s)}$ = 100 µm	-	16.0	-	K/kW

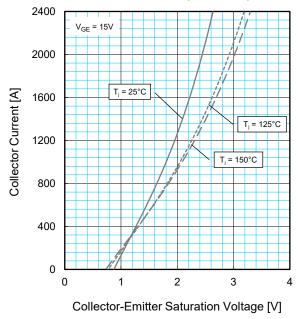
MECHANICAL CHARACTERISTICS

Itam	Symbol	Conditions		Limits		
Item S		Conditions		Тур.	Max.	Unit
Mounting torque		Main terminals screw: M8	7.0	-	20.0	N⋅m
Mounting torque	M_t	Mounting screw. M6	3.0	-	6.0	N⋅m
Mounting torque		Auxiliary terminals screw. M4	1.0	-	3.0	N⋅m
Mass	m	-	-	0.8	-	kg
Comparative tracking index	CTI	60		-	-	-
Clearance distance in air	da	Collector main terminal - Emitter main terminal Ferminal - Baseplate		-	-	mm
Creepage distance along surface	d_{s}	Collector main terminal - Emitter main terminal	15.0	-	-	mm
Creepage distance along surface	d_{s}	Terminal - Baseplate	15.0	-	-	mm
Internal inductance (C-E)	L _{P(C-E)}	1/2 module, IGBT part, T _C =25°C	-	22	-	nΗ
Internal lead resistance, CC'-EE'	R _{CC'+EE'}	1/2 module, IGBT part, T _c =25°C	-	0.16	-	mΩ

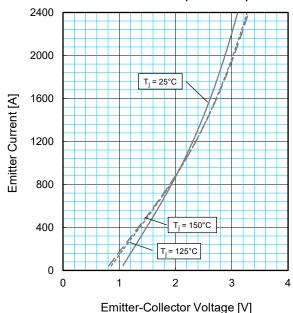




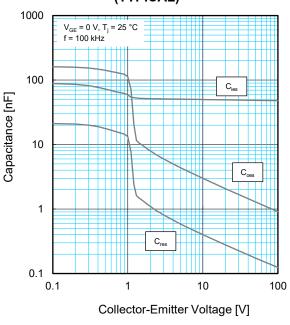
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



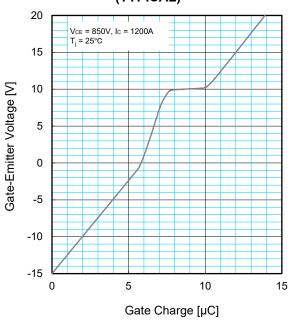
FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)



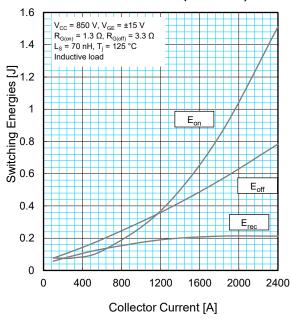
CAPACITANCE CHARACTERISTICS (TYPICAL)



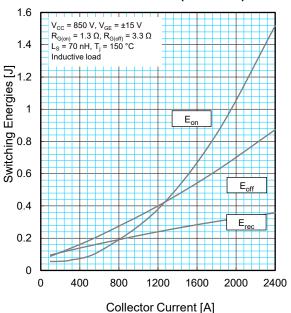
GATE CHARGE CHARACTERISTICS (TYPICAL)



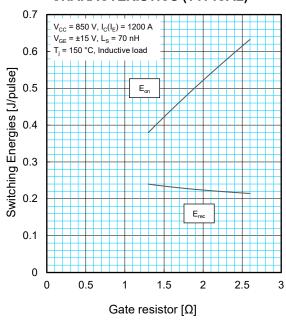
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



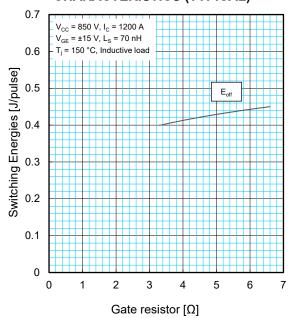
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



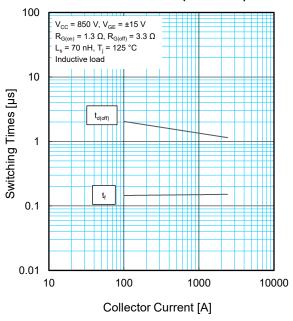
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



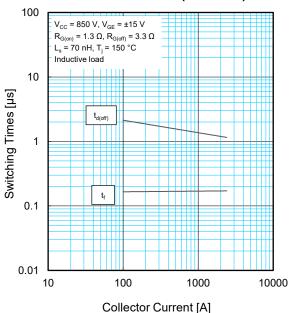
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



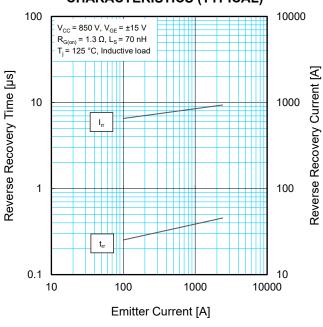
HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)



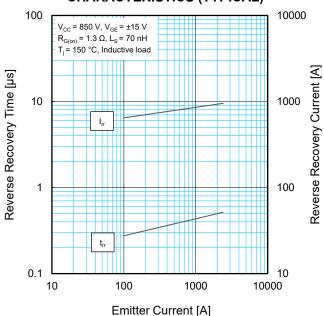
HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)



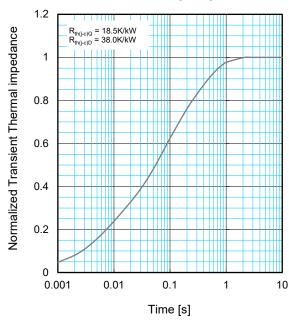
FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



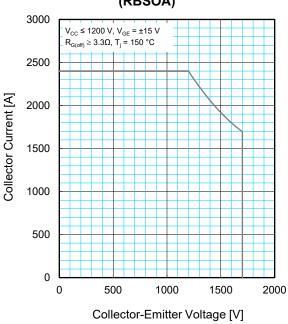
TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



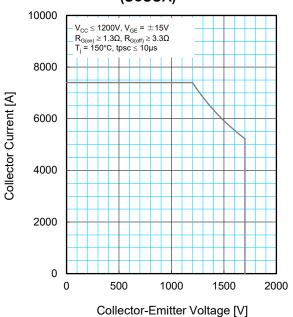
$$Z_{th(j-c)}(t) = \sum_{i=1}^{n} R_i \left\{ 1 - exp^{\left(-\frac{t}{\tau_i}\right)} \right\}$$

	1	2	3	4
R _i [K/kW] :	0.0096	0.1893	0.4044	0.3967
τ _i [sec.] :	0.0001	0.0058	0.0602	0.3512

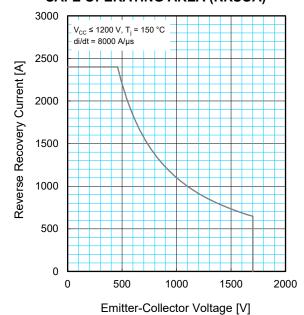
REVERSE BIAS SAFE OPERATING AREA (RBSOA)



SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)



FREE-WHEEL DIODE REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)



CM1200DC-34S1
HIGH POWER SWITCHING USE INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

Important Notice

The information contained in this datasheet shall in no event be regarded as a guarantee of conditions or characteristics. This product has to be used within its specified maximum ratings, and is subject to customer's compliance with any applicable legal requirement, norms and standards.

Except as otherwise explicitly approved by Mitsubishi Electric Corporation in a written document signed by authorized representatives of Mitsubishi Electric Corporation, our products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.

In usage of power semiconductor, there is always the possibility that trouble may occur with them by the reliability lifetime such as Power Cycle, Thermal Cycle or others, or when used under special circumstances (e.g. condensation, high humidity, dusty, salty, highlands, environment with lots of organic matter / corrosive gas / explosive gas, or situations which terminals of semiconductor products receive strong mechanical stress). Therefore, please pay sufficient attention to such circumstances. Further, depending on the technical requirements, our semiconductor products may contain environmental regulation substances, etc. If there is necessity of detailed confirmation, please contact our nearest sales branch or distributor.

The contents or data contained in this datasheet are exclusively intended for technically trained staff. Customer's technical departments should take responsibility to evaluate the suitability of Mitsubishi Electric Corporation product for the intended application and the completeness of the product data with respect to such application. In the customer's research and development, please evaluate it not only with a single semiconductor product but also in the entire system, and judge whether it's applicable. As required, pay close attention to the safety design by installing appropriate fuse or circuit breaker between a power supply and semiconductor products to prevent secondary damage. Please also pay attention to the application note and the related technical information.

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

Keep safety first in your circuit designs!

Mitsubishi Electric Corporation puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal injury, fire or property damage. Remember to give due consideration to safety when making your circuit designs, with appropriate measures such as (i) placement of substitutive, auxiliary circuits, (ii) use of non-flammable material or (iii) prevention against any malfunction or mishap.

Notes regarding these materials

- •These materials are intended as a reference to assist our customers in the selection of the Mitsubishi Electric Semiconductor product best suited to the customer's application; they do not convey any license under any intellectual property rights, or any other rights, belonging to Mitsubishi Electric Corporation or a third party.
- •Mitsubishi Electric Corporation assumes no responsibility for any damage, or infringement of any third-party's rights, originating in the use of any product data, diagrams, charts, programs, algorithms, or circuit application examples contained in these materials.
- •All information contained in these materials, including product data, diagrams, charts, programs and algorithms represents information on products at the time of publication of these materials, and are subject to change by Mitsubishi Electric Corporation without notice due to product improvements or other reasons. It is therefore recommended that customers contact Mitsubishi Electric Corporation or an authorized Mitsubishi Electric Semiconductor product distributor for the latest product information before purchasing a product listed herein.
- The information described here may contain technical inaccuracies or typographical errors. Mitsubishi Electric Corporation assumes no responsibility for any damage, liability, or other loss rising from these inaccuracies or errors.
- Please also pay attention to information published by Mitsubishi Electric Corporation by various means, including the Mitsubishi Electric Semiconductor home page (https://www.MitsubishiElectric.com/semiconductors/).
- •When using any or all of the information contained in these materials, including product data, diagrams, charts, programs, and algorithms, please be sure to evaluate all information as a total system before making a final decision on the applicability of the information and products. Mitsubishi Electric Corporation assumes no responsibility for any damage, liability or other loss resulting from the information contained herein.
- •Mitsubishi Electric Corporation semiconductors are not designed or manufactured for use in a device or system that is used under circumstances in which human life is potentially at stake. Please contact Mitsubishi Electric Corporation or an authorized Mitsubishi Electric Semiconductor product distributor when considering the use of a product contained herein for any specific purposes, such as apparatus or systems for transportation, vehicular, medical, aerospace, nuclear, or undersea repeater use.
- •The prior written approval of Mitsubishi Electric Corporation is necessary to reprint or reproduce in whole or in part these materials.
- •If these products or technologies are subject to the Japanese export control restrictions, they must be exported under a license from the Japanese government and cannot be imported into a country other than the approved destination.
- Any diversion or re-export contrary to the export control laws and regulations of Japan and/or the country of destination is prohibited.
- •Please contact Mitsubishi Electric Corporation or an authorized Mitsubishi Electric Semiconductor product distributor for further details on these materials or the products contained therein.

© MITSUBISHI FLECTRIC CORPORATION